

SINGLE 13-INPUT POSITIVE NAND GATE**DESCRIPTION**

The M74LS133P is a semiconductor integrated circuit containing one 13-input positive-logic NAND gate, usable as a negative logic NOR gate.

FEATURES

- High breakdown input voltage ($V_I \geq 15V$)
- Low power dissipation ($P_d = 2.5mW$ typical)
- High speed ($t_{pd} = 11ns$ typical)
- Low output impedance
- Wide operating temperature range ($T_a = -20 \sim +75^\circ C$)

APPLICATION

General purpose, for use in industrial and consumer equipment.

FUNCTIONAL DESCRIPTION

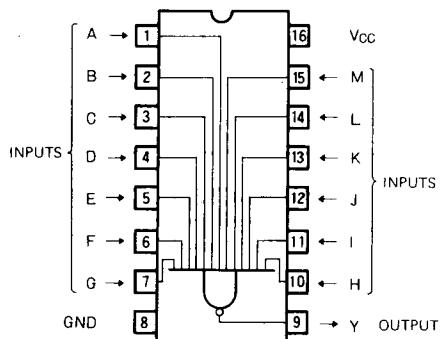
The use of PNP transistors for the inputs and active pull-up transistors for the outputs enables input high breakdown voltage, high speed, low power dissipation and high fan-out.

When inputs A through M are high, output Y is low and when one or more of the inputs is low, output Y is high.

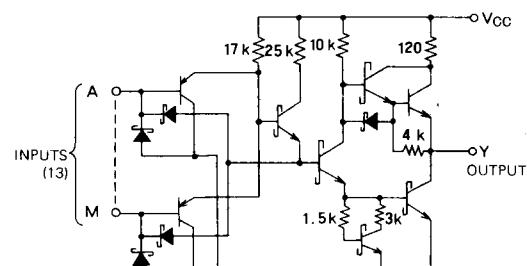
FUNCTION TABLE

A	N	Y
L	L	H
H	L	H
L	H	H
H	H	L

$N = B \cdot C \cdot D \cdot E \cdot F \cdot G \cdot H \cdot I \cdot J \cdot K \cdot L \cdot M$

PIN CONFIGURATION (TOP VIEW)

Outline 16P4

CIRCUIT SCHEMATIC

UNIT : Ω

ABSOLUTE MAXIMUM RATINGS ($T_a = -20 \sim +75^\circ C$, unless otherwise noted)

Symbol	Parameter	Conditions	Limits	Unit
V_{cc}	Supply voltage		$-0.5 \sim +7$	V
V_I	Input voltage		$-0.5 \sim +15$	V
V_o	Output voltage	High-level state	$-0.5 \sim V_{cc}$	V
T_{opr}	Operating free-air ambient temperature range		$-20 \sim +75$	$^\circ C$
T_{stg}	Storage temperature range		$-65 \sim +150$	$^\circ C$

SINGLE 13-INPUT POSITIVE NAND GATE

RECOMMENDED OPERATING CONDITIONS ($T_a = -20 \sim +75^\circ\text{C}$, unless otherwise noted)

Symbol	Parameter	Limits			Unit
		Min	Typ	Max	
V_{CC}	Supply voltage	4.75	5	5.25	V
I_{OH}	High-level output current $V_{OH} \geq 2.7\text{V}$	0		-400	μA
I_{OL}	Low-level output current $V_{OL} \leq 0.4\text{V}$	0		4	mA
		$V_{OL} \leq 0.5\text{V}$	0	8	mA

ELECTRICAL CHARACTERISTICS ($T_a = -20 \sim +75^\circ\text{C}$, unless otherwise noted)

Symbol	Parameter	Test conditions	Limits			Unit
			Min	Typ *	Max	
V_{IH}	High-level input voltage		2			V
V_{IL}	Low-level input voltage				0.8	V
V_{IC}	Input clamp voltage	$V_{CC} = 4.75\text{V}, I_{IC} = -18\text{mA}$			-1.5	V
V_{OH}	High-level output voltage	$V_{CC} = 4.75\text{V}, V_I = 0.8\text{V}$ $I_{OH} = -400\mu\text{A}$	2.7	3.4		V
V_{OL}	Low-level output voltage	$V_{CC} = 4.75\text{V}$	$I_{OL} = 4\text{mA}$	0.25	0.4	V
		$V_I = 2\text{V}$	$I_{OL} = 8\text{mA}$	0.35	0.5	V
I_{IH}	High-level input current	$V_{CC} = 5.25\text{V}, V_I = 2.7\text{V}$			20	μA
		$V_{CC} = 5.25\text{V}, V_I = 10\text{V}$			0.1	mA
I_{IL}	Low-level input current	$V_{CC} = 5.25\text{V}, V_I = 0.4\text{V}$			-0.4	mA
I_{OS}	Short-circuit output current (Note 1)	$V_{CC} = 5.25\text{V}, V_O = 0\text{V}$	-20		-100	mA
I_{ICCH}	Supply current, all inputs high	$V_{CC} = 5.25\text{V}, V_I = 0\text{V}$		0.35	0.5	mA
I_{ICCL}	Supply current, all inputs low	$V_{CC} = 5.25\text{V}, V_I = \text{Open}$		0.6	1.1	mA

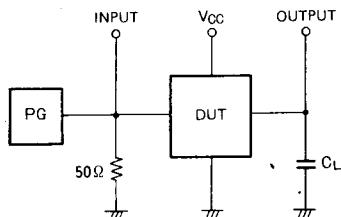
* : All typical values are at $V_{CC} = 5\text{V}$, $T_a = 25^\circ\text{C}$

Note 1: All measurements should be done quickly.

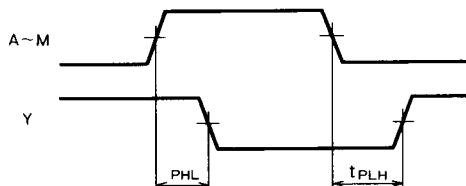
SWITCHING CHARACTERISTICS ($V_{CC} = 5\text{V}$, $T_a = 25^\circ\text{C}$, unless otherwise noted)

Symbol	Parameter	Test conditions	Limits			Unit
			Min	Typ	Max	
t_{PLH}	Low-to-high-level/high-to-low-level output propagation time	$C_L = 15\text{pF}$ (Note 2)		6	15	ns
t_{PHL}				16	38	ns

Note 2: Measurement circuit



TIMING DIAGRAM (Reference level = 1.3V)



(1) The pulse generator (PG) has the following characteristics:

PRR = 1MHz, $t_r = 6\text{ns}$, $t_f = 6\text{ns}$, $t_w = 500\text{ns}$, $V_p = 3\text{V}_{\text{p.p.}}$, $Z_0 = 50\Omega$.(2) C_L includes probe and jig capacitance.

PRECAUTION FOR USE

Connect pins not being used to the V_{CC} supply voltage.

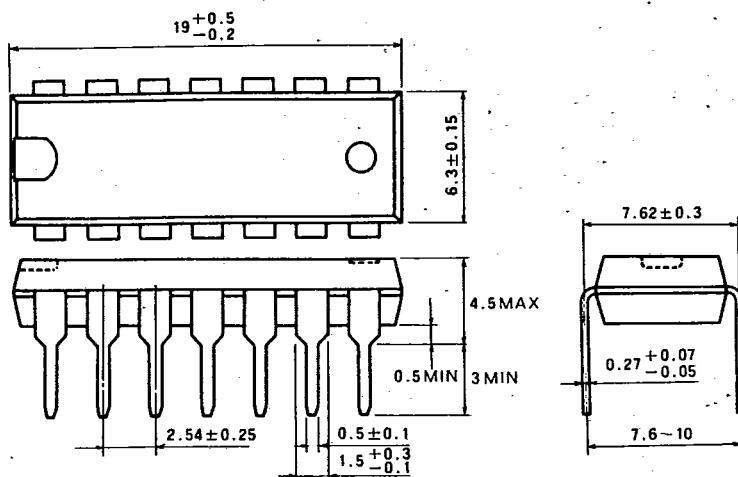
MITSUBISHI LSTTLs
PACKAGE OUTLINES

MITSUBISHI {DGTL LOGIC} 07E D | 6249827 0013561 3

T-90-20

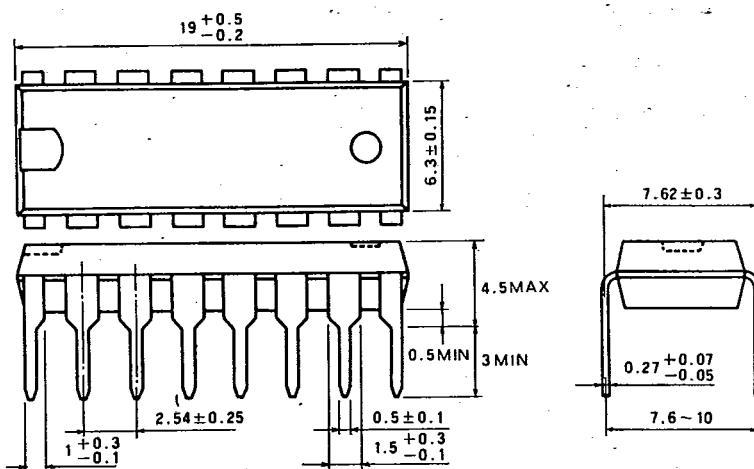
TYPE 14P4 14-PIN MOLDED PLASTIC DIL

Dimension in mm



TYPE 16P4 16-PIN MOLDED PLASTIC DIL

Dimension in mm



TYPE 20P4 20-PIN MOLDED PLASTIC DIL

Dimension in mm

